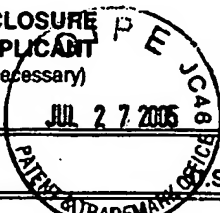


Form PTO-1449 U.S. DEPARTMENT OF COMMERCE  
(Rev. 2-32) PATENT AND TRADEMARK OFFICEATTY DOCKET NO.  
14316.06APPLICATION NO.  
UnknownINFORMATION DISCLOSURE  
STATEMENT BY APPLICANT  
(use several sheets if necessary)APPLICANT  
Matthew P. DugasFILING DATE  
HerewithGROUP ART UNIT  
Unknown

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A. Hainz

9/16/05

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	APPLICANT Matthew P. Dugas	
	FILING DATE Herewith	GROUP ART UNIT Unknown

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